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 APPLICANT
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U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
mqd		FLUDGER, et al. "Electrical Measurements of Multipath Interference in Distributed Raman Amplifiers" Journal of Lightwave Technology Vol. 19, No. 4 (April, 2001) pp. 536-545.
mqd		LEWIS, et al. "Characterization of Double Rayleigh Scatter Noise in Raman Amplifiers" IEEE Photonic Technology Letters Vol. 12, No. 5 (May, 2000) pp. 528-530.

EXAMINER

Mark Hellner

DATE CONSIDERED

6/17/2005

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